

<b>Notice of References Cited</b>	Application/Control No. 09/978,258	Applicant(s)/Patent Under Reexamination YONEZAWA, AKIRA	
	Examiner Kiet T. Nguyen	Art Unit 2881	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,504,164	01-2003	Yonezawa et al.	250/492.3
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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